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Quarterly Reliability Monitoring Results

Quarters: Q1/2022 to Q4/2023 Based on structural similarity

Supplier		User Part Number						
Nexperia B.V. Name of Laboratory Assembly reliability labs Based on AEC-Q101 Test		HPZR-C9V4-Q Part Description						
							Nexperia DHAM Zener SMD package	
		Test Conditions	Duration	# Lots	# Quantity	# Rejects		
			TEST					
			Pre- and Post-Stress					
# E1	Electrical Test	Tamb = 25 °C	N/A	see below	all parts	see below		
		JESD22-A113						
	B C	Bake Tamb = 125 °C	24 hours					
# 41	PC Decembring	Soak Tamb = 85 °C, RH = 85%	168 hours	1514	64420	0		
# A1	Preconditioning	Reflow soldering	3 cycles	1514	64430	0		
	HTRB	MIL-STD-750-1 M1038 Method A						
		Tj = Tjmax, VR = 80 % of rated reverse						
# B1	Bias	voltage	1000 hours	250	11400	0		
" 01	5100	MIL-STD-750-1	1000 110015	230	11100	0		
		M1038 Method B						
	SSOP	$T_j = T_j max$, $I_z = 100\%$ of max. datasheet						
# B1b	Steady State Operational	reverse current	1000 hours	44	1920	0		
	тс	JESD22-A104						
# A4	Temperature Cycling	-65 °C to Tjmax, not to exceed 150°C	1000 cycles	311	14080	0		
	UHAST	JESD22-A118						
# A3 or	Unbiased HAST	Tamb = 130 °C, RH = 85 %	96 hours	311	14080	0		
		JESD22-A102						
	AC	Tamb = 121 °C, RH = 100 %						
# A3 alt	Autoclave	Pressure = 205 kPa (29.7 psia)						
	H3TRB	JESD22-A101 Tamb = 85 °C, RH = 85%, VR = 80 % of						
# A2 alt	High Humidity High Temperature Reverse Bias		1000 hours	311	14080	0		
<i>π רו</i> ב מונ	Temperature Reverse Dias	MIL-STD-750 Method 1037	1000 110015	311	14000	0		
	IOL	ton = toff, devices powered to insure ΔT_i =						
# A5	Intermittent Operating Life	, , , ,	1000 hours	312	14120	0		
						-		
	RSH	JESD22-A111						
# C8	Resistance to Solder Heat	260 °C ± 5 °C	10 s	269	8070	0		
	SD							
# C10	Solderability	J-STD-002		19	6660	0		

[1] The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

Calculation of FIT and MTTF

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test #B1) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

2,68E+09
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